

VDS	RDS(on)	ID@25℃
1200V	40mΩ	68A

Applications:

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- EV Charging
- Motor Drives

Features:

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness

Benefits:

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Ordering Information

G		G ○—	ω ([♣]) · ω
S	RoHS	REACH	HF

Part Number	Package	Marking	Packing	Qty.
RSM120040W	TO-247-3	RSM120040W	Tube	30 PCS

Maximum Ratings (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
VDSmax	Drain - Source Voltage	1200	V	VGS=0V,ID =100μA	
VGSmax	Gate - Source Voltage	-8/+22	V	Absolute maximum values	
VGSop	Gate - Source Voltage	-4/+18	V	Recommended operational values	
ID	Continuous Drain	68	^	VGS=18V, TC =25℃	
ID	Current	49	A	VGS=18V, TC =100°C	
ID(pulse)	Pulsed Drain Current	100	Α	Pulse width tp limited by TJmax	
PD	Power Dissipation	340	W	TC =25℃, TJ =175℃	
TL	Solder Temperature	260	$^{\circ}$ C		
TI Tota	Operating Junction and	-55 to	$^{\circ}$ C		
TJ, Tstg	StorageTemperature	+ 175			



Electrical Characteristics (TJ= 25 °C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions Not	e
V(BR)D SS	Drain-Source Breakdown Voltage	120 0			٧	VGS=0V,ID =100μA	
) (CC(H-)	Gate Threshold	1.9	2.6	4.0	٧	VGS= VDS, IDS=9.5mA, TC =25°C	
VGS(th)	Voltage		1.8		٧	VGS= VDS, IDS=9.5mA, TC =175°C	
IDSS	Zero Gate Voltage Drain Current		1	100	μΑ	VDS= 1200V, VGS=0V	
IGSS	Gate-Source Leakage Current		10	250	nA	VGS=22V, VDS= 0V	
RDS(on)	Drain-Source on-state		40	53	mΩ	VGS=18V, ID =33.3A, TC =25℃	
KD3(0II)	Resistance		65			VGS=18V, ID =33.3A, TC =175℃	
Ciss	Input Capacitance		207 0			VGS=0V, VDS=1000 V,	
Coss	Output Capacitance		112		pF	f=1MHz, VAC=25 mV	
Crss	Reverse Transfer Capacitance		11			7 10012, 776 23 1117	
EON	Turn-On Switching Energy		141 0		μJ	VDS =800V, VGS =-4/18V, ID = 33.3A,	
EOFF	Turn-Off Energy		750			RG(ext) = 2.5Ω , L= 100μ H	
td(on)	Turn-On Delay Time		17				
tr	Rise Time		58			VDS =800V, VGS =-4/18 V	
td(off)	Turn-Off Delay Time		26		ns	ID = 33.3A, RG(ext) =2.5 Ω , RL =20 Ω	
tf	Fall Time		15				
RG(int)	Internal Gate Resistance		4.9		Ω	f=1 MHz, VAC=25mV	
Qgs	Gate to Source Charge		34		nC		
Qgd	Gate to Drain Charge		20		nC	VDS=800V, VGS=-4/18V ID =33.3A	
Qg	Total Gate Charge		121			10 00.0A	



Reverse Diode Characteristics (TJ= 25℃ unless otherwise specified)

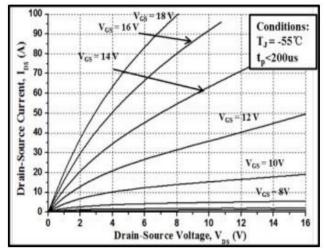
Symbol	Parameter	Тур.	Max	Unit	Test Conditions	Note
VCD	Die de Fermand Wellere	4.5		٧	VGS=-4V, ISD =20 A, TJ = 25℃	
VSD	Diode Forward Voltage	4.2		٧	VGS=-4V, ISD=20 A, TJ= 175℃	
IS	Continuous Diode Forward Current		51	Α	VGS=-4V,TC= 25°C	
trr	Reverse Recovery time	38		ns		
Qrr	Reverse Recovery Charge	109		nC	ISD= 33.3 A, VR = 800V	
Irrm	Peak Reverse Recovery Current	5		Α	VIX 500V	

Thermal Characteristics (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Тур.	Unit	Test Conditions	Note
RθJC	Thermal Resistance from Junction to Case	0.44	°C /\A/		
RθJA	Thermal Resistance From Junction to Ambient	40	°C/W		



Typical Feature Curve



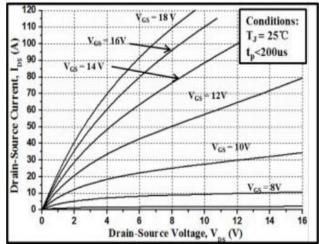
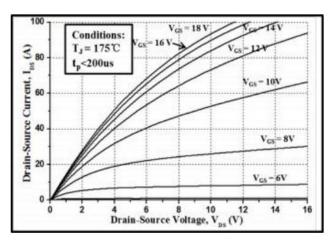


Figure 1. Output Characteristics T_J = -55C





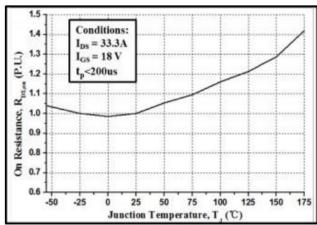
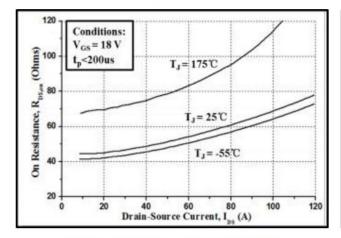


Figure 3. Output Characteristics T_J = 1750

Figure 4. Normalized On-Resistance vs. Temperature



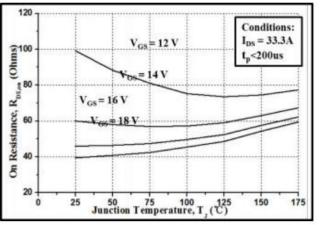
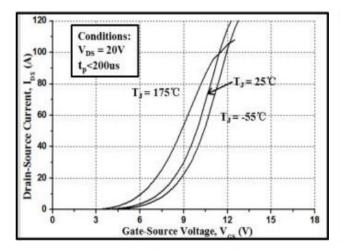
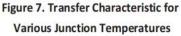


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage







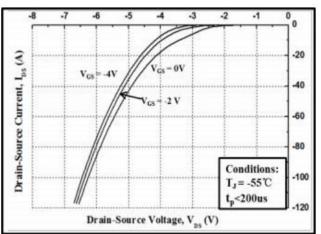


Figure 8. Body Diode Characteristic at -550

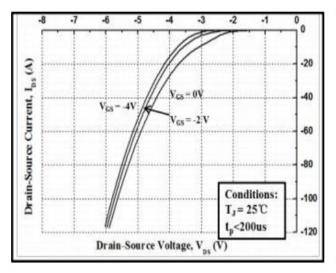


Figure 9. Body Diode Characteristic at 25C

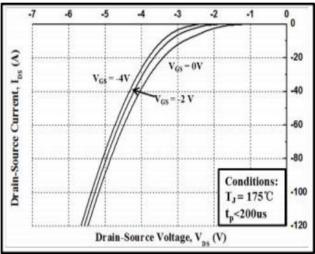


Figure 10. Body Diode Characteristic at 1750

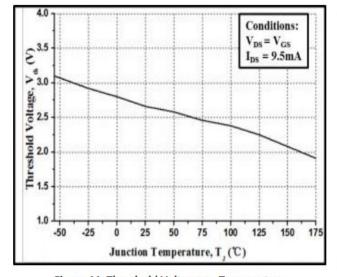


Figure 11. Threshold Voltage vs. Temperature

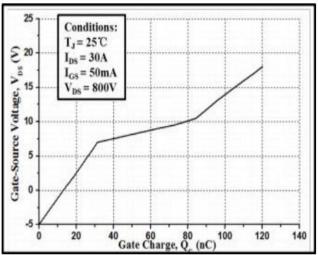
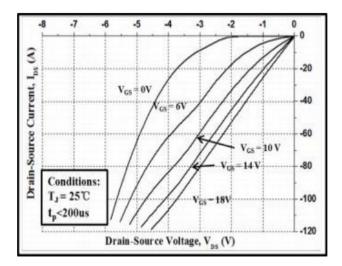


Figure 12. Gate Charge Characteristics

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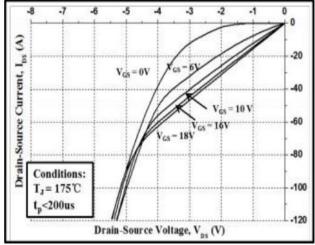
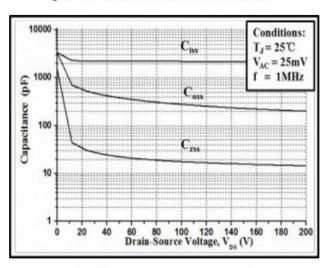


Figure 13. 3rd Quadrant Characteristic at 250

Figure 14. 3rd Quadrant Characteristic at 1750



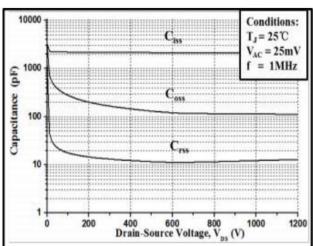


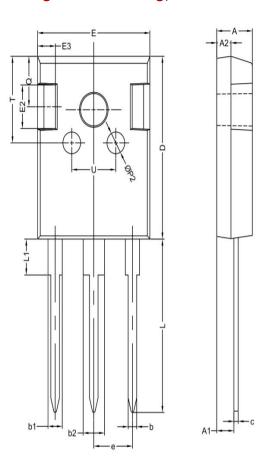
Figure 15. Capacitances vs. Drain-Source Voltage (0 - 200V)

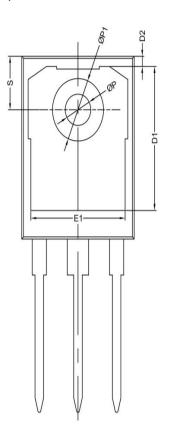
Figure 16. Capacitances vs. Drain-Source Voltage (0 - 1200V)





Package outline drawing(TO-247-3 Unit: mm)





W II		机械尺寸/mn	n		
符号	最小值	典型值	最大值		
Α	4.80	5.00	5.20		
A1	2.21	2.41	2.61		
A2	1.90	2.00	2.10		
b	1.10	1.20	1.35		
b1		2.00			
b2		3.00			
С	0.55	0.60	0.75		
D	20.80	21.00	21.20		
D1		16.55			
D2		1.20			
E	15.60	15.80	16.0		
E1		13.30			
E2		5.00			
E3		2.50			
е		5.44			
L	19.42	19.92	20.42		
L1		4.13			
Р	3.50	3.60	3.70		
P1		-	7.40		
P2		2.50			
Q		5.80			
S	6.05	6.15 6			
Т		10.00			
U		6.20			





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